

**Search Notes**

Application/Control No.

10/529,790

Examiner

RuiMeng Hu

Applicant(s)/Patent under  
Reexamination

SANO, TAKASHI

Art Unit

2618

**SEARCHED**

| Class | Subclass | Date      | Examiner |
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| 455   | 193.1-.3 | 2/23/2007 | RH       |
| 455   | 195.1    | 2/23/2007 | RH       |
| 455   | 197.2    | 2/23/2007 | RH       |
| 455   | 161.1    | 2/23/2007 | RH       |
| 455   | 160.1    | 2/23/2007 | RH       |
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**INTERFERENCE SEARCHED**

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

|  | DATE      | EXMR |
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| EAST (USPAT, US-PGPUB, EPO,<br>JPO, DERWENT, IBM_TDB) - See<br>Search History Printout | 2/23/2007 | RH   |
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